



<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>09875401</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>MILES, MARK W.</p>
	<p>Examiner</p> <p>Nguyen, Jennifer T</p>	<p>Art Unit</p> <p>2629</p>


Class	SubClass	Date	Examiner
345	173-178	7/3/06	JN

U.S. Patent and Trademark Office	Part of Paper No.:
----------------------------------	--------------------

<b>Interference Searched</b>  	Application/Control No.  09875401	Applicant(s)/Patent Under Reexamination  MILES, MARK W.
	Examiner Nguyen, Jennifer T	Art Unit 2629

Class	SubClass	Date	Examiner
187	18.01-18.03	7/3/06	JN
359	291, 247, 549, 584	7/3/06	JN

U.S. Patent and Trademark Office	Part of Paper No.:
----------------------------------	--------------------

<b>Search Notes</b>  	Application/Control No.  09875401	Applicant(s)/Patent Under Reexamination  MILES, MARK W.
	Examiner Nguyen, Jennifer T	Art Unit 2629

Notes	Date	Examiner
East, PAJ, IDS	7/3/06	JN

U.S. Patent and Trademark Office	Part of Paper No.:
----------------------------------	--------------------